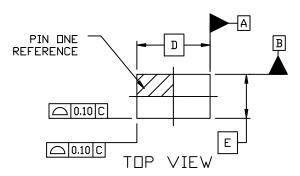
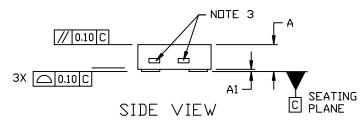
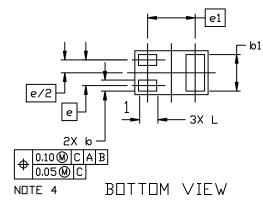


X2DFN3 1.0x0.6, 0.35P CASE 714AC ISSUE A

DATE 08 JAN 2019







GENERIC MARKING DIAGRAM*



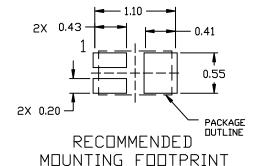
XX = Specific Device Code M = Date Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G", may or not be present. Some products may not follow the Generic Marking.

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. EXPOSED COPPER ALLOWED AS SHOWN.
- 4. ALL PAD LOCATIONS CONTROLLED WITH THIS POSITIONAL TOLERANCE.

	MILLIMETERS		
DIM	MIN.	N□M.	MAX.
Α	0.34	0.37	0.40
A1	0.00		0.05
b	0.10	0.15	0.20
b1	0.45	0.50	0.55
D	0.95	1.00	1.05
Ε	0.55	0.60	0.65
е	0.35 BSC		
e1	0.65 BSC		
L	0.20	0.25	0.30



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